

# DRV8806

SLVSBA3-JUNE 2012

# **QUAD SERIAL INTERFACE LOW-SIDE DRIVER IC**

Check for Samples: DRV8806

# **FEATURES**

- **4-Channel Protected Low-Side Driver** 
  - Four NMOS FETs With Overcurrent Protection
  - Integrated Inductive Catch Diodes
  - Serial Interface
  - Open/Shorted Load Detection
- 2-A (Single Channel On)/1-A (All Channels On) Maximum Drive Current per Channel (at 25°C)
- 8.2-V to 40-V Operating Supply Voltage Range
- **Thermally Enhanced Surface Mount Package** ٠

# APPLICATIONS

- **Relay Drivers** •
- **Unipolar Stepper Motor Drivers**
- **Solenoid Drivers** ٠
- **General Low-Side Switch Applications**

# DESCRIPTION

The DRV8806 provides a 4-channel low side driver with overcurrent protection. It has built-in diodes to clamp turn-off transients generated by inductive loads and can be used to drive unipolar stepper motors, DC motors, relays, solenoids, or other loads.

The DRV8806 can supply up to 2-A (single channel on) or 1-A (all channels on) continuous output current (with adequate PCB heatsinking at 25°C).

A serial interface is provided to control the output drivers. Fault status can be read through the serial interface. Multiple DRV8806 devices can be chained together to use a single serial interface.

Internal shutdown functions are provided for over current protection, short circuit protection, under voltage lockout and overtemperature and faults are indicated by a fault output pin.

The DRV8806 is available in a 16-pin HTSSOP package (Eco-friendly: RoHS & no Sb/Br).

## **ORDERING INFORMATION**<sup>(1)</sup>

PACKAGE <sup>(2)</sup>		ORDERABLE PART NUMBER	TOP-SIDE MARKING
	Reel of 2000	DRV8806PWPR	DRV8806
(HTSSOP) - PWP	Tube of 90	DRV8806PWP	DRV8806

(1) For the most current packaging and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at www.ti.com.

Package drawings, thermal data, and symbolization are available at www.ti.com/packaging. (2)



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**DEVICE INFORMATION** 

**Functional Block Diagram** 

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# DRV8806

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## Table 1. TERMINAL FUNCTIONS

NAME	PIN (HTSSOP)	I/O <sup>(1)</sup>	DESCRIPTION	EXTERNAL COMPONENTS OR CONNECTIONS
POWER AND G	ROUND		·	
GND	5, 12, PPAD	-	Device ground	All pins must be connected to GND.
VM	1	-	Device power supply	Connect to motor supply (8.2 V - 40 V).
CONTROL				
nENBL	8	I	Enable input	Active low enables outputs - internal pulldown
RESET	9	Ι	Reset input	Active-high reset input initializes internal logic – internal pulldown
LATCH	11	I	Latch input	Rising edge latches shift register to output stage falling edge latches fault data into output shift register – internal pulldown
SDATIN	14	I	Serial data input	Serial data input – internal pulldown
SDATOUT	15	OD	Serial data output	Serial data output - open drain output - internal pullup
SCLK	13	I	Serial clock	Serial clock input – internal pulldown
STATUS				
nFAULT	16	OD	Fault	Logic low when in fault condition (overtemp, overcurrent, open load) - open drain output
OUTPUT			•	·
OUT1	3	0	Output 1	Connect to load 1
OUT2	4	0	Output 2	Connect to load 2
OUT3	6	0	Output 3	Connect to load 3
OUT4	7	0	Output 4	Connect to load 4
VCLAMP	2	-	Output clamp voltage	Connect to VM supply, or zener diode to VM supply

(1) Directions: I = input, O = output, OD = open-drain output

#### PWP (HTSSOP) PACKAGE (TOP VIEW)



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## **ABSOLUTE MAXIMUM RATINGS**

over operating free-air temperature range (unless otherwise noted) (1) (2)

		VALUE	UNIT
VM	Power supply voltage range	-0.3 to 43	V
VOUTx	Output voltage range	-0.3 to 43	V
VCLAMP	Clamp voltage range	-0.3 to 43	V
SDATOUT, nFAULT	Output current	20	mA
	Peak clamp diode current <sup>(3)</sup>	2	А
	DC or RMS clamp diode current <sup>(3)</sup>	1	А
	Digital input pin voltage range	-0.5 to 7	V
SDATOUT, nFAULT	Digital output pin voltage range	–0.5 to 7	V
	Peak motor drive output current, t < 1 µS	Internally limited	А
	Continuous total power dissipation <sup>(3)</sup>	See Thermal Informat	tion table
TJ	Operating virtual junction temperature range <sup>(3)</sup>	-40 to 150	°C
T <sub>stg</sub>	Storage temperature range	-60 to 150	°C

(1) Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. All voltage values are with respect to network ground terminal.

(2)(3)

Power dissipation and thermal limits must be observed.

## THERMAL INFORMATION

		DRV8806	
	THERMAL METRIC <sup>(1)</sup>	PWP	UNITS
		16 PINS	
$\theta_{JA}$	Junction-to-ambient thermal resistance <sup>(2)</sup>	39.6	
θ <sub>JCtop</sub>	Junction-to-case (top) thermal resistance <sup>(3)</sup>	24.6	
θ <sub>JB</sub>	Junction-to-board thermal resistance <sup>(4)</sup>	20.3	°C 11/
ΨJT	Junction-to-top characterization parameter <sup>(5)</sup>	0.7	°C/W
Ψ <sub>JB</sub>	Junction-to-board characterization parameter <sup>(6)</sup>	20.1	
θ <sub>JCbot</sub>	Junction-to-case (bottom) thermal resistance <sup>(7)</sup>	2.3	

For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953. (1)

(2)The junction-to-ambient thermal resistance under natural convection is obtained in a simulation on a JEDEC-standard, high-K board, as specified in JESD51-7, in an environment described in JESD51-2a.

The junction-to-case (top) thermal resistance is obtained by simulating a cold plate test on the package top. No specific JEDEC-(3)standard test exists, but a close description can be found in the ANSI SEMI standard G30-88.

(4) The junction-to-board thermal resistance is obtained by simulating in an environment with a ring cold plate fixture to control the PCB temperature, as described in JESD51-8.

The junction-to-top characterization parameter,  $\psi_{JT}$ , estimates the junction temperature of a device in a real system and is extracted (5)from the simulation data for obtaining  $\theta_{JA}$ , using a procedure described in JESD51-2a (sections 6 and 7).

The junction-to-board characterization parameter,  $\psi_{JB}$ , estimates the junction temperature of a device in a real system and is extracted (6)from the simulation data for obtaining  $\theta_{JA}$ , using a procedure described in JESD51-2a (sections 6 and 7).

(7)The junction-to-case (bottom) thermal resistance is obtained by simulating a cold plate test on the exposed (power) pad. No specific JEDEC standard test exists, but a close description can be found in the ANSI SEMI standard G30-88.



## **RECOMMENDED OPERATING CONDITIONS**

		MIN	NOM	MAX	UNIT
VM	Power supply voltage range	8.2		40	V
V <sub>CLAMP</sub>	Output clamp voltage range <sup>(1)</sup>	0		40	V
	Continuous output current, single channel on, $T_A = 25^{\circ}C^{(2)}$			2	٨
IOUT	Continuous output current, four channels on, $T_A = 25^{\circ}C^{(2)}$			1	A

VCLAMP is not a power supply input pin - it only connects to the output clamp diodes.
Power dissipation and thermal limits must be observed.

## **ELECTRICAL CHARACTERISTICS**

 $T_A = 25^{\circ}C$ , over recommended operating conditions (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
POWER	SUPPLIES					
I <sub>VM</sub>	VM operating supply current	V <sub>M</sub> = 24 V		1.6	3	mA
V <sub>UVLO</sub>	VM undervoltage lockout voltage	V <sub>M</sub> rising			8.2	V
LOGIC-L	EVEL INPUTS (SCHMITT TRIGG	ER INPUTS WITH HYSTERESIS)				
VIL	Input low voltage				0.8	V
VIH	Input high voltage		2			V
V <sub>HYS</sub>	Input hysteresis			0.45		V
IIL	Input low current	VIN = 0	-20		20	μA
I <sub>IH</sub>	Input high current	VIN = 3.3 V			100	μA
R <sub>PD</sub>	Pulldown resistance			100		kΩ
nFAULT	OUTPUT (OPEN-DRAIN OUTPU	т)				
V <sub>OL</sub>	Output low voltage	I <sub>O</sub> = 5 mA			0.5	V
I <sub>OH</sub>	Output high leakage current	V <sub>O</sub> = 3.3 V			1	μA
SDATOU	T OUTPUT (OPEN-DRAIN OUTP	UT WITH INTERNAL PULLUP)				
V <sub>OL</sub>	Output low voltage	I <sub>O</sub> = 5 mA		0.5		V
V <sub>OH</sub>	Output high voltage	I <sub>O</sub> = 100 μA		4.5		V
LOW-SIC	DE FETS					
Р		$V_{M} = 24 \text{ V}, I_{O} = 700 \text{ mA}, T_{J} = 25^{\circ}\text{C}$		0.5		Ω
R <sub>DS(ON)</sub>	FET on resistance	$V_{M} = 24 V, I_{O} = 700 mA, T_{J} = 85^{\circ}C$		0.75	0.8	Ω
I <sub>OFF</sub>	Open load detect current		0	25	50	μA
HIGH-SI	DE DIODES					
V <sub>F</sub>	Diode forward voltage	V <sub>M</sub> = 24 V, I <sub>O</sub> = 700 mA, T <sub>J</sub> = 25°C		0.9		V
I <sub>OFF</sub>	Off state leakage current	$V_{\rm M} = 24 \ V, \ T_{\rm J} = 25^{\circ}{\rm C}$	-50		50	μA
OUTPUT	S					
t <sub>R</sub>	Rise time	$V_{M} = 24 \text{ V}, I_{O} = 700 \text{ mA}, \text{Resistive load}$	50		300	ns
t <sub>F</sub>	Fall time	$V_{\rm M}$ = 24 V, I <sub>O</sub> = 700 mA, Resistive load	50		150	ns
PROTEC	TION CIRCUITS					
I <sub>OCP</sub>	Overcurrent protection trip level		3		5	А
t <sub>OCP</sub>	Overcurrent protection deglitch time			3.5		μs
t <sub>OL</sub>	Open load detect deglitch time			15		μs
t <sub>RETRY</sub>	Overcurrent protection re-try time			1.2		ms
t <sub>TSD</sub>	Thermal shutdown temperature	Die temperature	150	160	180	°C

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## TIMING REQUIREMENTS

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

NO.	PARAMETER	DESCRIPTION	MIN MAX	UNIT
1	t <sub>CYC</sub>	Clock cycle time	62	ns
2	t <sub>CLKH</sub>	Clock high time	25	ns
3	t <sub>CLKL</sub>	Clock low time	25	ns
4	t <sub>SU(SDATIN)</sub>	Setup time, SDATIN to SCLK	5	ns
5	t <sub>H(SDATIN)</sub>	Hold time, SDATIN to SCLK	1	ns
6	t <sub>D(SDATOUT)</sub>	Delay time, SCLK to SDATOUT	15	ns
7	t <sub>W(LATCH)</sub>	Pulse width, LATCH	200	ns
8	t <sub>OE(ENABLE)</sub>	Enable time, nENBL to output low	50	ns
9	t <sub>D(LATCH)</sub>	Delay time, LATCH to output change	50	ns
-	t <sub>RESET</sub>	RESET pulse width	20	μs
10	t <sub>D(RESET)</sub>	Reset delay before clock	20	μs
11	tSTARTUP	Startup delay VM applied before clock	55	μs

(1) Not production tested.









# FUNCTIONAL DESCRIPTION

## **Output Drivers**

The DRV8806 contains four protected low-side drivers. Each output has an integrated clamp diode connected to a common pin, VCLAMP.

VCLAMP can be connected to the main power supply voltage, VM. It can also be connected to a zener or TVS diode to VM, allowing the switch voltage to exceed the main supply voltage VM. This connection can be beneficial when driving loads that require very fast current decay, such as unipolar stepper motors.

In all cases, the voltage on the outputs must not be allowed to exceed the maximum output voltage specification.

## **Serial Interface Operation**

The DRV8806 is controlled with a simple serial interface. Logically, the interface is shown in Figure 2.



Figure 2. Serial Interface Operation

Data is shifted into a temporary holding shift register in the part using the SDATIN pin, one bit at each rising edge of the SCLK pin, while LATCH is low. Data is shifted from the last bit to the SDATOUT pin, so multiple devices may be daisy-chained together using a single serial interface.

Note that the SDATOUT pin has a weak pullup to an internal 4.5-V power supply, which can support driving another DRV8806 SDATIN pin at clock frequencies of up to 1 MHz without an external pullup. To operate at faster than 1-MHz clock frequency or to interface to devices operating at other supply voltages, a pullup resistor of approximately 1 k $\Omega$  to the chosen logic supply voltage should be used.

A rising edge on the LATCH pin latches the data from the temporary shift register into the output stage.

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#### Fault Output Register

The DRV8806 contains circuitry to detect open or shorted loads. The status of the loads can be read via the serial interface. The logic is shown in Figure 3.



Figure 3. Fault Output

To overcome any leakage currents to accurately sense an open load, a small current source is connected to each output pin. This source pulls approximately  $25-\mu A$  of current to ground. The voltage on the output pin is sensed during the time that the output is off, and if the voltage on the pin is less than 1.2 V (indicating that there is no load connected) after the open load deglitch time, the OPEN\_FAULT latch is set. This latch is cleared whenever the output bit is set.

When the output is turned on, if an overcurrent (OCP) fault is detected, the channel will be turned off and the OCP\_FAULT latch is set. This latch will be cleared whenever the output bit is cleared.

The state of the OCP\_FAULT and OPEN\_FAULT signals is combined into a single fault bit per channel, and loaded into a shift register while the LATCH pin is low. When the LATCH pin is taken high, the fault data is latched into the shift register at the first falling edge of SCLK. Data may then be shifted out on the SDATOUT pin on each falling edge of the SCLK pin.

Note that the LATCH signal must be high for a minimum of 200 ns before valid data can be clocked out.

The nFAULT pin will be driven active low whenever any of the OCP\_FAULT or OPEN\_FAULT latches are set, as well as whenever there is an overtemperature condition.



#### **Daisy-Chain Connection**

Two or more DRV8806 devices may be connected together to use a single serial interface. The SDATOUT pin of the first device in the chain is connected to the SDATIN pin of the next device. The SCLK, LATCH, RESET, and nFAULT pins are connected together.



Figure 4. Daisy-Chain Connection

Figure 5 shows an example of a serial transaction, writing the output bits, and then reading the fault status bits, using two devices connected together in a daisy-chain.

Note that the LATCH signal must be high for a minimum of 200 ns before valid data can be clocked out.



Figure 5. Daisy-Chain Serial Transaction

## nENBL and RESET Operation

The nENBL pin enables or disables the output drivers. nENBL must be low to enable the outputs. nENBL does not affect the operation of the serial interface logic. Note that nENBL has an internal pulldown.

The RESET pin, when driven active high, resets internal logic, including the OCP fault. All serial interface registers are cleared. Note that RESET has an internal pulldown. An internal power-up reset is also provided, so it is not required to drive RESET at power-up.

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## **Protection Circuits**

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The DRV8806 is fully protected against undervoltage, overcurrent and overtemperature events.

#### **Overcurrent Protection (OCP)**

An analog current limit circuit on each FET limits the current through the FET by removing the gate drive. If this analog current limit persists for longer than the  $t_{OCP}$  deglitch time (approximately 3.5 µs), the driver will be disabled and the nFAULT pin will be driven low. The driver will remain disabled for the  $t_{RETRY}$  retry time (approximately 1.2 ms), then the fault will be automatically cleared. The fault will be cleared immediately if either RESET pin is activated or VM is removed and re-applied.

#### **Thermal Shutdown (TSD)**

If the die temperature exceeds safe limits, all output FETs will be disabled and the nFAULT pin will be driven low. Once the die temperature has fallen to a safe level, operation will automatically resume.

#### Undervoltage Lockout (UVLO)

If at any time the voltage on the VM pin falls below the undervoltage lockout threshold voltage, all circuitry in the device will be disabled, and internal logic will be reset. Operation will resume when VM rises above the UVLO threshold.



## THERMAL INFORMATION

### Thermal Protection

The DRV8806 has thermal shutdown (TSD) as described above. If the die temperature exceeds approximately 150°C, the device will be disabled until the temperature drops to a safe level.

Any tendency of the device to enter TSD is an indication of either excessive power dissipation, insufficient heatsinking, or too high an ambient temperature.

## **Power Dissipation**

Power dissipation in the DRV8806 is dominated by the power dissipated in the output FET resistance, or RDS(ON). Average power dissipation of each FET when running a static load can be roughly estimated by Equation 1:

$$P = R_{DS(ON)} \bullet (I_{OUT})^2$$

(1)

where P is the power dissipation of one FET,  $R_{DS(ON)}$  is the resistance of each FET, and  $I_{OUT}$  is equal to the average current drawn by the load. Note that at start-up and fault conditions this current is much higher than normal running current; these peak currents and their duration also need to be taken into consideration. When driving more than one load simultaneously, the power in all active output stages must be summed.

The maximum amount of power that can be dissipated in the device is dependent on ambient temperature and heatsinking.

Note that  $R_{DS(ON)}$  increases with temperature, so as the device heats, the power dissipation increases. This must be taken into consideration when sizing the heatsink.

## Heatsinking

The PowerPAD<sup>™</sup> package uses an exposed pad to remove heat from the device. For proper operation, this pad must be thermally connected to copper on the PCB to dissipate heat. On a multi-layer PCB with a ground plane, this can be accomplished by adding a number of vias to connect the thermal pad to the ground plane. On PCBs without internal planes, copper area can be added on either side of the PCB to dissipate heat. If the copper area is on the opposite side of the PCB from the device, thermal vias are used to transfer the heat between top and bottom layers.

For details about how to design the PCB, refer to TI Application Report SLMA002, "PowerPAD<sup>™</sup> Thermally Enhanced Package" and TI Application Brief SLMA004, "PowerPAD<sup>™</sup> Made Easy", available at www.ti.com.

In general, the more copper area that can be provided, the more power can be dissipated.



## PACKAGING INFORMATION

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	Eco Plan <sup>(2)</sup>	Lead/ Ball Finish	MSL Peak Temp <sup>(3)</sup>	Samples (Requires Login)
DRV8806PWP	ACTIVE	HTSSOP	PWP	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	
DRV8806PWPR	ACTIVE	HTSSOP	PWP	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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# PACKAGE MATERIALS INFORMATION

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## TAPE AND REEL INFORMATION

#### REEL DIMENSIONS

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#### TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

## TAPE AND REEL INFORMATION

\*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
DRV8806PWPR	HTSSOP	PWP	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

TEXAS INSTRUMENTS

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# PACKAGE MATERIALS INFORMATION

14-Jul-2012



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
DRV8806PWPR	HTSSOP	PWP	16	2000	367.0	367.0	35.0

PWP (R-PDSO-G16)

PowerPAD<sup>™</sup> PLASTIC SMALL OUTLINE



All linear dimensions are in millimeters. NOTES: Α.

- Β. This drawing is subject to change without notice.
- Body dimensions do not include mold flash or protrusions. Mold flash and protrusion shall not exceed 0.15 per side. C.
- This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPad D. Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 for information regarding recommended board layout. This document is available at www.ti.com <a href="http://www.ti.com">http://www.ti.com</a>. E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
- E. Falls within JEDEC MO-153

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NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPad Thermally Enhanced Package, Texas Instruments Literature No. SLMA002, SLMA004, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <http://www.ti.com>. Publication IPC-7351 is recommended for alternate designs.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.

F. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

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